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Proving Safety Properties of FPGAs

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ABSTRACT

FPGAs are increasing in complexity and being used as important components of safety-critical systems. Emerging safety standards require analytic reasoning to demonstrate the safety of FPGAs in such systems. This report describes a method which uses a synchronous process algebra to produce formal proof that an FPGA program satisfies safety properties, and demonstrates its use in the specification of safety functions for a safety-critical system.

Categories and Subject Descriptors
D.2 [Software]: Software Engineering

General Terms
Synchronous receptive process theory

Keywords
SRPT, FPGA, safety critical systems

1. INTRODUCTION

Programmable logic devices (PLDs) are increasing in size and complexity. From their origins as more flexible versions of Programmable Logic Arrays (PLAs), they are now able to compute complex and useful calculations at high speeds. Becker et al [2] describe an implementation of a CDMA (Code Division Multiple Access) receiver, a key component of 3rd generation mobile phones, on a new design of dynamically reconfigurable coarse-grained FPGA. This illustrates how reconfigurable devices can perform an important computation to take significant processing load off a conventional modern microprocessor.

For some years the development and testing of software in high-integrity systems has been the subject of stringent safety standards. In the past two years new emerging standards have started to require similar rigour in the development of safety-related electronic hardware, such as FPGAs, due to these devices being used to perform safety-critical functions within such systems.

This paper proposes a method for description of an programmed LUT (Look-Up Table) FPGA using a process algebra, and shows how the resulting description can be used to make rigorous proofs about certain properties of the system.

Section 2 of this paper describes the current issues of safety and correctness in high-integrity systems. Section 3 describes the synchronous receptive process algebra SRPT. Section 4 shows how SRPT can be used in specification and proof of properties of simple FPGA elements. Section 5 gives an example of the proof of safety properties of a system safety monitor. Finally, section 6 summarises the work done to date and outlines future directions for the work.

2. SAFETY

2.1 Definitions

In this paper we make use of the following definition:

a safety-critical system is a collection of components acting together where interruption of the normal function of one or more components may cause injury or loss of life.

The interested reader is referred to Leveson [10] pp 156, 181 for the details of this definition. Note that a failure need not lead to injury or loss of life for the system to be safety-critical; it is enough that the possibility exists. It is important to note that the context of a system affects its criticality; a system is not safety-critical until it is powered up in its intended environment and is able to cause injury by its failure.

Failure is the nonperformance or inability of the system or component to perform its intended function for a specified time under specified conditions. A fault is a higher-order event; all failures are faults, but not all faults are failures. For example, a fault can caused by a component behaving correctly, not failing, but reacting to an erroneous external signal. (Leveson pp 172-173)

2.2 Assessing Integrity

Integrity in the context of safety-critical systems and their components is measured in terms of the probability of total or partial failure. A high-integrity system is expected to fail with lower frequency than a low-integrity system.

The emerging European safety standard IEC 61508 [8] specifies four Safety Integrity Levels – SIL 1, SIL 2, SIL 3
and SIL 4 – which express the expected frequency of a dangerous failure in a system. SIL 4, the highest integrity level, specifies a frequency of less than 1 failure per 10^8 demands for a low-demand mode of operation, or less than 1 failure per 10^4 hours for high-demand or continuous operation.

There is normally a requirement for all components of a system at SIL N to be SIL N themselves. However, it is possible to argue for a reduced SIL for a specific component if it can be shown that the component has a limited effect on the system. A ‘white box’ safety analysis procedure, such as that described in [14], aims to trace the output data of each component through the system and determine whether it can contribute to any predetermined system hazard. As lower SILs will, in general, be cheaper to produce than higher ones, by reducing the required SIL of the component, the required development effort can be reduced accordingly.

2.3 Relevant Standards

There are many standards relevant to the development of safety-critical systems. Those chosen for a particular project will depend on the requirements of the customer and the legal system of the country or countries in which it is to be used. However, there are few widely-used standards which are specifically intended to cover the use of complex digital logic in safety-critical systems. The two standards presented below are the most important European standards for this area at the moment.

IEC Standard 61508 [8] (abbreviated to as IEC 61508) is intended to apply across multiple industry sectors, setting out a generic safety management approach for systems with electrical, electronic or programmable electronic components. It addresses functional safety in systems, i.e. those safety properties that depend on the system functioning correctly.

Part 2 of IEC 61508 contains the safety requirements for any electrical, electronic or programmable components of the system. It specifies those aspects of hardware failure which should be addressed by the developer, for instance that PLDs need to detect such hardware faults as stuck-at failures for registers, bus faults and welded-together contacts. Techniques such as those described in [13] could be used to analyse PLDs for some classes of these failures.

The developer must also consider the properties of the conventional software in the system (that software executed on one or more microprocessors), such as correct ‘watchdog’ operation and information redundancy, with the analysis list determined by the system’s SIL. Interestingly, the programmable part of the PLDs in such systems is not addressed in detail; there are requirements for aspects of the design to be analysed, but no concrete requirements for implementation language or related aspects as there are for co

UK Defence Standard 00-54 [12] is a new interim standard for the use of safety-related electronic hardware (SREH) in UK defence equipment. It relates to systems developed under the UK Defence Standard 00-56 safety systems document [11] (or an equivalent international standard such as IEC 61508).

Defence Standard 00-54 contains the following recommendations which are of particular interest to developers wishing to incorporate PLDs in safety-critical systems.

(§12.2.1) A formally defined language which supports mathematically based reasoning and the proof of safety properties shall be used to specify a custom design;

(§13.4.1) Safety requirements shall be incorporated explicitly into the Hardware Specification using a formal representation; and

(§13.4.4) Correspondence between the Hardware Specification and the design implementation shall be demonstrated by analytical means, subject to assumptions about physical properties of the implementation.

where ‘custom design’ refers to the non-standard components of the electronic component under examination, and in particular to an FPGA’s program data. The standard’s guidelines provide more information about the motivation behind the standard:

The principal concern which has caused this Interim Standard to be produced is that electronic hardware designs used in critical applications have been getting steadily more complicated […] Therefore the focus of this Interim Standard is on analysis and proof to supplement test.

2.4 Summary

We see then that new safety standards require us to be able to reason analytically about the safety and correctness of programmable logic devices within safety-critical systems. The following section describes a mathematics-based model which allows us to do this.

3. SYNCHRONOUS RECEPTIVE PROCESS THEORY

The process algebra CSP [7] has been used successfully to demonstrate partial correctness of protocols and industrial parallel systems. Supporting tools such as FDR [3] allow semi-automatic analysis of relatively large and complex parallel systems, proving them free from deadlock and livelock. However, CSP falls short of the ideal for describing FPGAs since it is asynchronous (two events may not happen at the same time) and not receptive (CSP processes can refuse events. In this section we summarise the key features of SRPT, and show how it may be used to describe digital circuits and prove statements about their properties.

3.1 Basic SRPT

An SRPT system description has an alphabet \( \Sigma \) of events which are variables in the system. There are some processes \( \{ P_k \} \), for which each process \( P \in \{ P_k \} \) has an input alphabet \( \iota P \) in \( \Sigma \) and output alphabet \( oP \) in \( \Sigma \). For each \( P, \iota P \) and \( oP \) must be disjoint, finite, and their union must be non-empty. \( \iota P \) consists of the events to which process \( P \) may react, and \( oP \) the events which the process controls. There is a set \( \text{Var} \) of process variables, each of which will range over \( \{ P_k \} \).
Processes are defined using the following grammar:

\[
P ::= \perp_{\ell, o} \quad \text{chaos} \\
| \quad \pi \quad \text{process variable} \\
| \quad P \cap P \quad \text{non-deterministic choice} \\
| \quad [O ? X \rightarrow P_X] \quad \text{output prefix} \\
| \quad P \parallel P \quad \text{parallel composition} \\
| \quad P \setminus O \quad \text{hiding} \\
| \quad P[S] \quad \text{renaming} \\
| \quad \mu x : I, O \cdot P \quad \text{recursion} \tag{1}
\]

In the above definition, \( O \) denotes a subset of the output alphabet \( oP \), \( X \) denotes a subset of the input alphabet \( iP \) and \( S \) is a bijection over \( \Sigma \). \( P_X \) specifies a process in a family with the same alphabets as \( P \), but where the processes are parameterised by subsets \( X \in \mathbb{P}(iP \cup oP) \).

Since we will use the output prefix form extensively, it is worth providing an informal definition here. The above definition specifies that the process will, during the next timestep, output all events in \( O \) and receive some set of events \( X \) from its input alphabet. From timestep \( t+1 \) onwards it behaves exactly like process \( P_X \).

Each definition of a process \( P \) is in terms of a reaction to input events (a subset of \( iP \)). Unlike CSP, an SRPT process cannot refuse an event which is in \( iP \); it simply observes such events happening. What it can do is react to those events by signalling events in its output alphabet. The synchronous nature of SRPT means that processes may receive and output any number of events at once.

As a simple example, an AND gate has no control over its two inputs, but exerts control over its output according to the values of the inputs in the previous timestep. It cannot provide an output at time \( t \) which relates to inputs received at time \( t \); there is always a delay before the reaction is visible.

Barnes [1] defines a set of axioms and derives laws for algebraic combination of terms from this grammar. For example:

\[
\text{a-10 : } [B ? X \rightarrow P_X] \parallel [C ? Y \rightarrow Q_X] \equiv [((B \cup C) ? Z \rightarrow P_{(Z \cup C) \cap iP}) \parallel Q_{(Z \cup B) \cap oP}] \tag{2}
\]

This states that when combining two output-prefixes processes, we initially see the combined output of both processes, which we would naturally expect. From then on \( P \)'s behaviour may additionally be affected if its input alphabet includes one or more events from the output alphabet of \( Q \), and vice versa.

We will not use non-deterministic choice in our process specifications; Barnes' axioms show that if it is not in a system to start with then it will never arise (it is never on the right hand side of an axiomatic expression if it is not on the left hand side).

As an example of an SRPT system definition, in the following subsection we will describe a 1-cycle \( n \)-bit adder with the SRPT algebra.

### 3.2 Example – Adder

An \( n \)-bit binary adder ADD\(_n\), may be defined, for any positive fixed \( n \), within SRPT. We represent each wire coming into and out of the adder with an event in the process alphabets; input wires have events in the input alphabet, and output wires have events in the output alphabet. An event occurring at a specified time denotes a logical high voltage on that wire at that time; the lack of an event denotes a logical low voltage.

Given the following disjoint sets of events:

\[
A = \{a_1, \ldots, a_n\}, B = \{b_1, \ldots, b_n\} \\
Z = \{z_1, \ldots, z_{n+1}\}
\]

then we define the main process in the system as:

\[
\iota ADD_n = A \cup B \\
oADD_n = Z \\
ADD_n(R) = \{R ? X \rightarrow ADD_n(X \cap A + X \cap B)\} \\
ADD_n = ADD_n(\emptyset)
\]

where we choose an encoding of the natural numbers in each of \( A, B \) and \( Z \), and define the \( + \) operator to map pairs of encoded numbers to the encoding of their sum:

\[
+: \mathbb{P}A \times \mathbb{P}B \rightarrow \mathbb{P}Z
\]

The above definition of ADD\(_n\) states that at each time tick \( t \) the ADD\(_n\) outputs events from \( Z \) taken from its parameter \( R \), then works out its next parameter by adding the numbers represented by the \( A \) and \( B \) events in that time tick's input.

Note that our process definitions parametrise processes to tell them what to output. This effectively encodes state within the processes, though in this example state at time \( t \) never affects the process after time \( t+1 \). The actual process \( ADD_n \) is arbitrarily defined in our example to output 0 on the first clock tick.

An example “run” for ADD\(_2(\emptyset)\) could be as shown in Figure 1. Note that the environment controls the subsets of \( A \) and \( B \) that appear; only the \( Z \) events are controlled by the process.

### 3.3 Composition

SRPT allows us to compose processes to form larger ones, in serial or in parallel. Parallel composition is done with the \( \parallel \) operator, but the most useful composition is normally serial since this allows us to break down a calculation into multiple stages. There is no explicit serial composition operator in SRPT; instead, composition in a system is effected by renaming process alphabets so that output events in one process are input events in another process. Composition is a key tool to allow us to build complex systems out of relatively simple processes. We now present an example of composition.

An 8-bit adder ADD\(_8\) could be formed out of smaller adders as follows. Defining the process events:

\[
A = \{a_1, \ldots, a_8\}, B = \{b_1, \ldots, b_8\} \\
Z = \{z_1, \ldots, z_8\} \\
H = \{h_1, \ldots, h_{10}\}
\]

we get the alphabets:

\[
\iota ADD8 = A \cup B \\
oADD8 = Z
\]
In a given system, each process $P$ with input alphabet $I$ and output alphabet $O$ has a semantics defined in terms of its set of traces:

$$RT_{I,O} = (\mathcal{P}(I \cup O))^*$$  \hspace{1cm} (11)

A trace $t \in RT_{I,O}$ consists of a sequence of sets of events: $t : \text{seq} \mathcal{P}(I \cup O)$. Each element of the sequence corresponds to an (non-negative integer) time value of the global clock, and gives the events in $I$ and $O$ for that process which happen at that time.

Barnes defines the following closure conditions for a set $T$ of traces for the above process $P$. In these conditions, $s$ and $r$ are traces, $(~)$ and $\parallel$ delimit a trace element and $\prec$ is the trace concatenator.

\begin{align*}
\text{I} & : \langle ~ \rangle \in T \\
\text{II} & : s \prec r \in T \Rightarrow s \prec T \\
\text{III} & : s \prec (X) \in T \land Y \subseteq I \Rightarrow s \prec ((X \cap O) \cup Y) \in T
\end{align*}

(12)

Conditions I and II are general properties of a trace semantics, requiring prefix closure of the set of traces. Condition III requires explanation: it states that the environment can offer any subset of input events at a given step, and that output at that step must be independent of the input at that step.

$RM$, the underlying model for the language, is the set of all triples $(I, O, T)$ where $I$ and $O$ are finite disjoint input and output alphabets of $\Sigma$ and $T$ is a set of traces which satisfies the above closure conditions. Each element $t \in RM$ then represents a unique process. We can group elements of $RM$ by input and output alphabets: $RM^{I,O}$ denotes the set of all processes with input alphabet $I$ and output alphabet $O$. $RM_f$ is the set of all traces in $RM$.

The full derivation of semantic functions is given in [1] §5.4; again, we summarise.

The binding function $BIND_R$ maps from a set $Var$ of process variables to $RM$. This is what the user is effectively defining when he or she writes the process definitions and decides on the names of the process variables.

The semantic function $M_{\Sigma}$ maps each process term to an element of $RM$. The associated function $T_{\Sigma}$ maps process terms to $RM_T$, and $\iota$, $o$ map process terms to their input and output alphabets $\subseteq \Sigma$. Hence where $\sigma$ represents an element of $BIND_R$ we have:

$$M_{\Sigma}[P]\sigma = (\rho[P]\sigma, o[P]\sigma, T_{\Sigma}[P]\sigma)$$

(13)

This can be read as “Given the user definition $\sigma$ of $P$ and associated SRPT processes, $M_{\Sigma}$ maps $P$ onto its input alphabet, output alphabet, and the set of all traces valid for it.”

All that then remains is to define $\iota$, $o$ and $T_{\Sigma}$ for each of the process terms. The interested reader is referred to Barnes for details of these definitions.

4. SRPT SPECIFICATION AND PROOF

To provide specifications for the actions of a process, we make statements about its traces. We take as a generic example the process for an $n$-bit FPGA cell $CELL_{n,f}$ pointwise computing a function $f : \mathbb{P}A \times \mathbb{P}B \rightarrow \mathbb{P}Z$, defined as follows:
\[ t \text{CELL}_{n,f} = A \cup B \]
\[ o \text{CELL}_{n,f} = Z \]
\[ \text{CELL}_{n,f}(R) = [[R ? X \rightarrow \text{CELL}_{n,f}(f(X \cap A, X \cap B))] \]
\[ \text{CELL}_{n,f} = \text{CELL}_{n,f}(0) \quad (14) \]

We assume that \( A, B \) and \( Z \) are disjoint subsets of \( \Sigma \).
The specification for \( \text{CELL}_{n,f} \) would be as follows:

\[ \forall t \in \text{Tr}[\text{CELL}_{n,f}] \sigma : \]
\[ \forall i \in \mathbb{N} : \]
\[ \forall C \in \mathbb{P} A : \]
\[ \forall D \in \mathbb{P} B : \]
\[ t[i] \cap A = C \quad \land \]
\[ t[i] \cap B = D \quad \land \]
\[ \#t > i \Rightarrow t[i+1] \cap Z = f(C, D) \quad (15) \]

where \( t[i] \) refers to the \( i \)th element of the trace \( t \). This can be read as “if the trace at step \( i \) has input events \( C \) from set \( A \) and \( D \) from set \( B \) then the output events in the trace at step \( i + 1 \) must represent the result of \( f(C, D) \)”.

For correctness, we must prove:

**Lemma 1.**

\[ \forall E \subseteq Z : \]
\[ \forall t \in \text{Tr}[\text{CELL}_{n,f}(E)] \sigma : \]
\[ \#t > 0 \Rightarrow t[0] \cap Z = E \quad (16) \]

i.e. the output set \( E \) passed as a parameter to \( \text{CELL}_{n,f} \) will always appear as the first output.

This arises from Barnes’ definition for output prefix:

\[ \text{Tr}([[B \equiv X \rightarrow P_Y] \sigma = \{()\} \cup \{(B \cup Y) \sim s | Y \subseteq I \land s \in \text{Tr}[P_Y \sigma]\} \quad (17) \]

where \( I = \text{eval}([[B \equiv X \rightarrow P_Y] \sigma \), i.e. the user’s representation of the input alphabets of this process.

To prove Lemma 1, substitute

\[ B = E \quad P_X = \text{CELL}_{n,f}(f(X \cap A, X \cap B)) \quad (18) \]

into Equation 17, giving:

\[ \text{Tr}[\text{CELL}_{n,f}(E)] \sigma = \{()\} \cup \{(E \cup Y) \sim s | Y \subseteq I \land s \in \text{Tr}[\text{CELL}_{n,f}(f(Y \cap A, Y \cap B))] \sigma\} \quad (19) \]

and note that \( Y \subseteq I \) cannot contain any elements of \( Z \) since \( Z \) is the output alphabet \( O \) and SRPT bans intersection of \( I \) and \( O \). Therefore the output events in the first element of any non-null trace must be exactly \( E \). □

We have shown that, as long as the right \( E \) is computed, \( \text{CELL}_{n,f}(E) \) will give the correct outputs on the next step. This is an apparently simple result, but important so that the foundation for higher-level analytical work is solid.

**Lemma 2.**

\[ \forall E \subseteq Z : \]
\[ \forall i \in \mathbb{N} : \]
\[ \forall t \in \text{Tr}[\text{CELL}_{n,f}(E)] \sigma : \]
\[ (t = s \sim r) \land (\#s = i) : \]
\[ \exists F \subseteq Z \quad s.t. \]
\[ r \in \text{Tr}[\text{CELL}_{n,f}(F)] \sigma \quad (20) \]

i.e. after any number \( i \) of steps of the trace \( t \) of \( \text{CELL}_{n,f}(E) \), the trace \( r \) formed by steps \( i + 1 \) onward of \( t \) is the trace of \( \text{CELL}_{n,f}(F) \) for some \( F \).

The proof is by induction on \( i \). For \( i = 1 \) we must show:

\[ \forall E \subseteq Z : \]
\[ \forall t \in \text{Tr}[\text{CELL}_{n,f}(E)] \sigma : \]
\[ (t = (U \sim r)) \quad \text{for some } U, r \]
\[ \exists F \subseteq Z \quad s.t. \]
\[ r \in \text{Tr}[\text{CELL}_{n,f}(F)] \sigma \quad (21) \]

Substituting

\[ F = f(Y \cap A, Y \cap B) \]
\[ U = E \cup Y \]
\[ r = s \quad (22) \]

into Equation 19 gives us:

\[ \text{Tr}[\text{CELL}_{n,f}(E)] \sigma = \{()\} \cup \{(U) \sim r | r \in \text{Tr}[\text{CELL}_{n,f}(F)] \sigma\} \quad (23) \]

and we have the desired result that traces satisfying Equation 23 match the specification in Equation 21, proving the base case. □

The induction step is to show that if Equation 20 is valid \( \forall i \in 1..N \) then it is valid for \( i = N + 1 \). We want to show that:

\[ \forall E \subseteq Z : \]
\[ \forall t \in \text{Tr}[\text{CELL}_{n,f}(E)] \sigma : \]
\[ (t = h \sim g) \land (\#h = N + 1) : \]
\[ \exists F \subseteq Z \quad s.t. \]
\[ g \in \text{Tr}[\text{CELL}_{n,f}(F)] \sigma \quad (24) \]

i.e. if after \( N \) steps the process is still behaving like the process \( \text{CELL}_{n,f}(R) \) for some \( R \) then after the next step it is behaving like \( \text{CELL}_{n,f}(F) \) for some \( F \).

We substitute \( h = s \sim (X \cup Y) \) and \( r = (X \cup Y) \sim g \), where \( X \subseteq I \) and \( Y \subseteq O \), into Equation 24 to expand the hypothesis to:

\[ \forall E \subseteq Z : \]
\[ \forall t \in \text{Tr}[\text{CELL}_{n,f}(E)] \sigma : \]
\[ (t = s \sim r) \land (\#s = N) \land (s[N] = (X \subseteq I) \cup (Y \subseteq O)) \Rightarrow \exists F \subseteq Z \quad s.t. \]
\[ r \in \text{Tr}[\text{CELL}_{n,f}(F)] \sigma \quad (25) \]

We note that the process described in the last line is in fact \( \text{CELL}_{n,f}(Y) \), and use Equation 19 to get:
\[ \forall E \in Z : \]
\[ \forall t \in T \exists (CELL_{m,f}(E)) \sigma \quad \text{s.t.} \]
\[ (t = s \sim r) \land \#s = N \land \]
\[ (s[N] = (X \subseteq I) \cup (Y \subseteq O)) \Rightarrow \]
\[ r \in T \exists (CELL_{m,f}(Y)) \sigma \quad (26) \]

The induction hypothesis gives us:

\[ \forall E \in Z : \]
\[ \forall t \in T \exists (CELL_{m,f}(E)) \sigma \quad \text{s.t.} \]
\[ (t = s \sim r) \land \#s = N \land \]
\[ \exists F \subseteq Z \quad \text{s.t.} \]
\[ r \in T \exists (CELL_{m,f}(F)) \sigma \quad (27) \]

which is equivalent, so we have the desired result. \( \square \)

Combining Lemmas 1 and 2 gives us the proof that all the traces of \( CELL_{m,f} \) satisfy the specification in Equation 15.

The result is applicable to all stateless one-cycle cells (i.e., those cells where output at time \( t+1 \) is solely dependent on input at time \( t \)), and is a useful foundation for proof at a higher level of abstraction. We give an example of this in the following section.

5. SAFETY MONITOR EXAMPLE

5.1 System Definition

For a substantial example, we take a safety-critical sub-system of a hypothetical military aircraft stores management system (SMS). The SMS is designed to control the arming and release of ordnance from hardpoints on the aircraft. The main relevant hazards of the SMS are the uncommanded arming or release of ordnance, which could result in destruction of the host aircraft or the dropping of ordnance on friendly territory. Such a system is often rated at SIL-3 or SIL-4, requiring the most rigorous demonstrations of safety.

The control of a typical SMS is mostly implemented in software on a conventional microprocessor, with digital and analogue devices providing support where required, and a bus such as the MIL STD 1553 allowing communication with other parts of the system such as the ordnance release units and the pilot’s release controls. We assume that the safety-critical sub-system under examination consists of the microprocessor with coupled memory, bus interface and programmable logic devices, since this is what has final control over release and arming of all ordnance.

Programmable logic is useful in such systems because the systems typically have hard real-time constraints. The microprocessors used in these systems tend to be several years behind the leading edge due to issues of reliability and the long development cycle of a safety-critical system. It is sometimes difficult to get everything done within the required time frame. Programmable logic can take simple but CPU-intensive tasks away from the main processor and make it easier to meet the system constraints. The normal alternative to programmable logic is the use of an ASIC, but the small production run of most safety-critical systems and the frequency of requirements changes may mean that using an ASIC would be significantly more expensive than using programmable logic.

5.2 System Safety

The safety features of this system will include:

- a watchdog timer which must be reset every 25ms or it will shut down the system (to stop or restart a hung system);
- the use of keywords to command dangerous actions; and
- voting for readings from safety-critical sensors.

One convention for software is to have the watchdog resetting code as the last event in the main program loop, each iteration of which is designed to complete in just less than the watchdog time. This means that if the stack gets corrupted or the program goes off into an unanticipated path then the watchdog should be able to shut down the system before too much harm is done.

A keyword is a unique data value which is written to a specific mapped memory location (and hence to the controller of an actuator in the system) to enable a dangerous action. Any other value written to that location will have no effect. Some systems command a shutdown if bad keywords are persistently written to a location.

We aim to encapsulate as many safety functions as possible in programmable logic devices and reason about their correctness there rather than attempt to prove safety properties of software. This is not to say that we can then ignore the safety of the software – far from it, but by moving functionality to an FPGA we reduce the size of the program and it is (generally) easier to reason about the behaviour of a small program than a large one.

We shall now describe and specify several safety-related processes.

5.3 Watchdog Timer

The Watchdog Timer has a single input, which is toggled by software to reset the timer, and a single output which is typically used to raise a high-priority interrupt and trigger a system shutdown.

The SRPT description of the watchdog \( WATCH \) which shuts down after \( k + 1 \) steps without an input toggle is:

\[ \tau WATCH = \{ w \} \]
\[ \sigma WATCH = \{ d \} \]
\[ WATCH = W0k(k) \quad (28) \]

where event \( w \) represents a high voltage on the watchdog input, and \( d \) represents a high voltage on the system-disabling watchdog output.

The \( W0k(x) \) process describes a watchdog where the last input toggle was 0 and there are \( x \) steps left until shutdown trigger. \( W1k \) is the same except that the last input toggle was 1.

\[ W0k(0) = ![\{ d \} ?X \rightarrow W0k(0)] \]
\[ W1k(0) = ![\{ d \} ?X \rightarrow W1k(0)] \]
\[ \forall x \geq 1 : \]
\[ W0k(x) = ![\emptyset ?X \rightarrow W1k(x)] \]
\[ W1k(x) = ![\emptyset ?X \rightarrow W0k(x)] \quad (29) \]
where \( A < B > C \) is read “if \( B \) is true then do \( A \), otherwise do \( C \).”

The trace specification on \( \text{WATCH}_t \) for each trace \( t \) is as follows. First, the detection of “\( w \) stuck-on” input:

\[
\forall i \in \mathbb{N} \quad w \notin t[i] \land w \notin t[i+1] : (\forall j \in 1..(k+1) : w \notin t[i+j]) \Rightarrow (\forall m \geq (k+2) : d \in t[i+m]) \quad (30)
\]

An example of \( w \) being “stuck-on” is shown in Figure 3. Next, the detection of stuck-off input:

\[
\forall i \in \mathbb{N} \quad w \in t[i] \land w \notin t[i+1] : (\forall j \in 1..(k+1) : w \notin t[i+j]) \Rightarrow (\forall m \geq (k+2) : d \in t[i+m]) \quad (31)
\]

Note that these specifications as written won’t detect the case that the process always or never receives \( w \) as an input. This is to reduce visual complexity of the specifications. They also do not require that the watchdog only output \( d \) when a failure has occurred.

It is a partial specification for the watchdog timer. It is not compact, mostly because we do not use abbreviating functions in the descriptions for clarity. If we now define

\[
\text{breaks} : \mathcal{T}_N \times \mathbb{P} \Sigma \rightarrow \text{seq} \mathbb{N}
\]

\[
\text{breaks}(t, x) = \{ i | i = 1 \lor \{ (x) \cap t[i] \neq \{x\} \cap t[i+1] \} \}
\]

so that \( \text{breaks}(t, x) \) gives a list of the points in the trace \( t \) where event \( x \) starts or ends appearing, then we could rewrite the specification of \( \text{WATCH}_t \) as:

\[
(\forall i \leq b : d \notin t[i]) \land (\forall i \geq (b+1) : d \in t[i]) \quad (33)
\]

where:

\[
b = B[a] + (k+1)
\]

\[
B = \text{breaks}(t, w)
\]

\[
a = \min m : B[m+1] - B[m] \geq (k+1)
\]

This is a complete specification for the watchdog, and has also patched the hole of not catching all-\( w \) or never-\( w \) sequences.

5.4 Keyword Checker

A keyword checker is a process which takes as input a \( w \)-bit keyword along with a \( w \) lines which denote the actuator to activate. No more than one of the actuator lines may be raised at any one time.

When an actuator line is raised, the checker validates the given keyword against an internal table: the result is one of ON, OFF or BAD. If ON then the checker raises the appropriate actuator output line. If OFF or BAD then it lowers the line, and if BAD or more than one input actuator line is raised then it sets a “failure” output.

The process description is as follows:

\[
P = \{ p_1 \ldots p_a \}
\]

\[
Q = \{ q_1 \ldots q_b \}
\]

\[
R = \{ r_1 \ldots r_c \}
\]

\[
I = \iota \text{KEYW}_{w,a} = P \cup Q
\]

\[
O = o\text{KEYW}_{w,a} = R \cup \{f\}
\]

\[
\text{KEYW}_{w,a} = \text{KEYW}_{w,a}(0,0) \quad (35)
\]

\( P \) events are actuator selection, \( Q \) events form keywords, and \( R \) events are actuator controls.

The process \( \text{KEYW}_{w,a}(f, X) \) will output events in \( X \), identify which actuator is being requested, check the supplied keyword, adjust the table \( f \) mapping actuator to ON or OFF accordingly, then transition to a \( \text{KEYW}_{w,a} \) process passing the updated table and, if any failure has occurred, the \( f \) failure event. We will not provide a full SRPT description here for the sake of brevity. Instead we will turn to the specification.

The keyword evaluation is given by \( \text{words} : \mathcal{P}Q \times \mathbb{N} \rightarrow \{ \text{ON}, \text{OFF}, \text{BAD} \} \)

\[
\text{words} : \mathcal{P}Q \times \mathbb{N} \rightarrow \{ \text{ON}, \text{OFF}, \text{BAD} \} \quad (36)
\]

The specification of each trace \( t \in \mathcal{T}_N \) is as follows:

\[
\forall i \in \mathbb{N} : \#(P \cap t[i]) \geq 2 \Rightarrow t[i+1] \land O = \{f\}
\]

\[
\#(P \cap t[i]) \leq 1 \Rightarrow \forall j \in 1 \ldots a : \text{last}(i, j) = \text{ON} \quad \Leftrightarrow \quad p_j \in t[i+1]
\]

\( \text{words}(Q \cap t[i], j) = \text{BAD} \land P \cap t[i] = \{p_j\} \Rightarrow f \in t[i+1] \quad (37) \)

where:

\[
\text{last}(i, j) = \text{words}(Q \cap t[i], j) \text{ s.t. } n = \max m \text{ s.t. } (P \cap t[m]) = \{p_j\} \land m \leq i
\]

or \( \text{last}(i, j) = \text{OFF} \) if no such \( n \)

returns the last legitimate action for actuator \( j \) at or before trace index \( i \).

5.5 Sensor Voter

A number of sensors require a voter to check their readings and forward them to the main processor along with a “failed” bit. We now address specifying this voter.

We assume that each sensor has three binary indicators, and that the correct output of the sensor, output by the voter, is taken by majority voting from the indicators. We also require that a sensor be regarded as failed if one channel has been wrong for \( k \) consecutive tests, and that failure is permanent once it occurs. Hence the voter will give a voted sensor output \( v \) and a failure output \( f \).

\[
\iota \text{VOTER}_k = \{ c_1, c_2, c_3 \}
\]

\[
o\text{VOTER}_k = \{ v, f \}
\]

\[
\text{VOTER}_k = \text{VOTER}_k(0, 0) \quad (39)
\]

Again, we do not provide a full description of the process \( \text{VOTER}_k(g, X) \). Suffice it to say that \( X \) provides the next output events, as before, and \( g \) counts the number of consecutive divergences from majority vote of each sensor input line.

The specification must first define the majority voting:
This report has contributed towards that goal.

ability to reason about the correctness of SRPT processes.
piling a program from SPARK Ada to a set of SRPT pro-
description. SPARK Ada has a formal definition, and com-
pressing in a few lines and yet make rigorous and useful
properties in a rigorous way. We have also seen that it pro-
model non-trivial FPGA programs and prove certain safety

6.1 Work to date

6. CONCLUSIONS

6.2 Future work

Decomposition of an FPGA program into logically co-
herent blocks must currently be done manually. The au-
thors are investigating the use of high level languages such as
Handel-C and SPARK Ada for compilation directly to
SRPT processes.

Reasoning about CSP processes is made easier by mod-
eiling tools such as FDR. It may be possible to produce a
similar modelling tool for SRPT, providing simple analysis
on possible traces of a process using analytic means. Clearly,
for SRPT to be used in real system development programs
there needs to be appropriate and effective tools support.

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